## ESD8101, ESD8111

## ESD Protection Diodes <br> Ultra Low Capacitance ESD Protection Diode for High Speed Data Line

The ESD81x1 Series ESD protection diodes are designed to protect high speed data lines from ESD. Ultra-low capacitance and low ESD clamping voltage make this device an ideal solution for protecting voltage sensitive high speed data lines.

## Features

- Low Capacitance ( 0.20 pF Typ, I/O to GND)
- Protection for the Following IEC Standards:

IEC 61000-4-2 (Level 4)

- Low ESD Clamping Voltage
- These Devices are $\mathrm{Pb}-$ Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- USB 3.0/3.1
- MHL 2.0
- eSATA

MAXIMUM RATINGS $\left(T_{J}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Rating | Symbol | Value | Unit |
| :--- | :---: | :---: | :---: |
| Operating Junction Temperature Range | $\mathrm{T}_{\mathrm{J}}$ | -55 to +150 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature Range | $\mathrm{T}_{\mathrm{stg}}$ | -55 to +150 | ${ }^{\circ} \mathrm{C}$ |
| Lead Solder Temperature - | $\mathrm{T}_{\mathrm{L}}$ | 260 | ${ }^{\circ} \mathrm{C}$ |
| Maximum (10 Seconds) |  |  |  |
| ESD8101: | ESD |  |  |
| IEC 61000-4-2 Contact |  | $\pm 23$ | kV |
| IEC 61000-4-2 Air |  | $\pm 23$ | kV |
| ESD811: |  | $\pm 30$ | kV |
| IEC 61000-4-2 Contact |  | $\pm 30$ | kV |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

See Application Note AND8308/D for further description of survivability specs.


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MARKING
DIAGRAMS


T, F, Q = Device Code

## PIN CONFIGURATION

 AND SCHEMATIC

ORDERING INFORMATION
See detailed ordering and shipping information on page 2 of this data sheet.

## ELECTRICAL CHARACTERISTICS

( $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted)

| Symbol | Parameter |
| :---: | :--- |
| $\mathrm{V}_{\mathrm{RWM}}$ | Working Peak Voltage |
| $\mathrm{I}_{\mathrm{R}}$ | Maximum Reverse Leakage Current @ $\mathrm{V}_{\mathrm{RWM}}$ |
| $\mathrm{V}_{\mathrm{BR}}$ | Breakdown Voltage @ $\mathrm{I}_{\mathrm{T}}$ |
| $\mathrm{I}_{\mathrm{T}}$ | Test Current |
| $\mathrm{V}_{\text {HOLD }}$ | Holding Reverse Voltage |
| $\mathrm{I}_{\mathrm{HOLD}}$ | Holding Reverse Current |
| $\mathrm{R}_{\mathrm{DYN}}$ | Dynamic Resistance |
| $\mathrm{I}_{\mathrm{PP}}$ | Maximum Peak Pulse Current |
| $\mathrm{V}_{\mathrm{C}}$ | Clamping Voltage $@ \mathrm{I}_{\mathrm{PP}}$ <br> $\mathrm{V}_{\mathrm{C}}=\mathrm{V}_{\text {HOLD }}+\left(\right.$ l $\left._{\mathrm{PP}}{ }^{*} \mathrm{R}_{\mathrm{DYN}}\right)$ |



ELECTRICAL CHARACTERISTICS $\left(T_{A}=25^{\circ} \mathrm{C}\right.$ unless otherwise specified)

| Parameter | Symbol | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reverse Working Voltage | $V_{\text {RWM }}$ | I/O Pin to GND |  |  | 3.3 | V |
| Breakdown Voltage | $V_{B R}$ | $\mathrm{I}_{\mathrm{T}}=1 \mathrm{~mA}, \mathrm{I} / \mathrm{O}$ Pin to GND | 5.5 | 7.9 | 8.6 | V |
| Reverse Leakage Current | $\mathrm{I}_{\mathrm{R}}$ | $\mathrm{V}_{\mathrm{RWM}}=3.3 \mathrm{~V}$, I/O Pin to GND |  |  | 1.0 | $\mu \mathrm{A}$ |
| Reverse Holding Voltage | $\mathrm{V}_{\text {HOLD }}$ | I/O Pin to GND |  | 2.1 |  | V |
| Holding Reverse Current | IHOLD | I/O Pin to GND |  | 17 |  | mA |
| ESD8111 Clamping Voltage | $\mathrm{V}_{\mathrm{C}}$ | $\mathrm{I}_{\mathrm{PP}}=7.1 \mathrm{~A},(8 / 20 \mu s$ pulse $)$ |  |  | 8.0 | V |
| ESD8101, ESD8111 Clamping Voltage TLP (Note 1) | $\mathrm{V}_{\mathrm{C}}$ |  |  | $\begin{aligned} & \hline 6.5 \\ & 10 \end{aligned}$ |  | V |
| Dynamic Resistance | $\mathrm{R}_{\text {DYN }}$ | I/O Pin to GND |  | 0.46 |  | $\Omega$ |
| Junction Capacitance | $\mathrm{C}_{J}$ | $\mathrm{V}_{\mathrm{R}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ |  | 0.2 | 0.4 | pF |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. ANSI/ESD STM5.5.1 - Electrostatic Discharge Sensitivity Testing using Transmission Line Pulse (TLP) Model.

TLP conditions: $\mathrm{Z}_{0}=50 \Omega, \mathrm{t}_{\mathrm{p}}=100 \mathrm{~ns}, \mathrm{t}_{\mathrm{r}}=4 \mathrm{~ns}$, averaging window; $\mathrm{t}_{1}=30 \mathrm{~ns}$ to $\mathrm{t}_{2}=60 \mathrm{~ns}$.

ORDERING INFORMATION

| Device | Package | Shipping $^{\dagger}$ |
| :--- | :---: | :---: |
| ESD8101FCT5G | DSN2 <br> (Pb-Free) | $10,000 /$ Tape \& Reel |
| ESD8111FCT5G | WLCSP2 <br> (Pb-Free) | $10,000 /$ Tape \& Reel |
| ESD8111PFCT5G | WLCSP2 Side wall Isolated 0201 <br> (Pb-Free) | $10,000 /$ Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## ESD8101, ESD8111

TYPICAL CHARACTERISTICS


Figure 1. ESD8101 CV Characteristics


Figure 3. ESD8101 S21 Insertion Loss


Figure 5. ESD8101 Capacitance over Frequency


Figure 2. ESD8111 CV Characteristics


Figure 4. ESD8111 S21 Insertion Loss


Figure 6. ESD8111 Capacitance over Frequency

## ESD8101, ESD8111

TYPICAL CHARACTERISTICS


Figure 7. ESD8101 Positive TLP I-V Curve


Figure 8. ESD8111 Positive TLP I-V Curve


Figure 10. ESD8111 Negative TLP I-V Curve

IEC 61000-4-2 Spec.

| Level | Test Volt- <br> age (kV) | First Peak <br> Current <br> (A) | Current at <br> $\mathbf{3 0} \mathbf{~ n s ~ ( A ) ~}$ | Current at <br> $\mathbf{6 0 ~ n s ~ ( A ) ~}$ |
| :---: | :---: | :---: | :---: | :---: |
| 1 | 2 | 7.5 | 4 | 2 |
| 2 | 4 | 15 | 8 | 4 |
| 3 | 6 | 22.5 | 12 | 6 |
| 4 | 8 | 30 | 16 | 8 |



Figure 11. IEC61000-4-2 Spec

## Transmission Line Pulse (TLP) Measurement

Transmission Line Pulse (TLP) provides current versus voltage ( $\mathrm{I}-\mathrm{V}$ ) curves in which each data point is obtained from a 100 ns long rectangular pulse from a charged transmission line. A simplified schematic of a typical TLP system is shown in Figure 12. TLP I-V curves of ESD protection devices accurately demonstrate the product's ESD capability because the 10 s of amps current levels and under 100 ns time scale match those of an ESD event. This is illustrated in Figure 13 where an 8 kV IEC 61000-4-2 current waveform is compared with TLP current pulses at 8 A and 16 A . A TLP I-V curve shows the voltage at which the device turns on as well as how well the device clamps voltage over a range of current levels.


Figure 12. Simplified Schematic of a Typical TLP System


Figure 13. Comparison Between 8 kV IEC 61000-4-2 and 8 A and 16 A TLP Waveforms


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.

| MILLIMETERS |  |  |
| :---: | :---: | :---: |
| DIM | MIN | MAX |
| A | 0.165 | 0.195 |
| A1 | --- | 0.030 |
| b | 0.177 | 0.193 |
| D | 0.435 | BSC |
| E | 0.230 | BSC |
| e | 0.270 | BSC |
| L | 0.112 | 0.128 |

GENERIC
MARKING DIAGRAM*
${ }^{0} \mathrm{x}$
$\mathrm{X}=$ Specific Device Code
*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present.

RECOMMENDED SOLDER FOOTPRINT*


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# X4DFN2, $0.60 \times 0.30,0.36 P$ 

CASE 152AX
ISSUE G
DATE 12 APR 2019


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS

|  | MILLIMETERS |  |  |
| :---: | :---: | :---: | :---: |
| DIM | MIN | NOM | MAX |
| A | 0.175 | 0.200 | 0.225 |
| A1 | 0.018 REF |  |  |
| b | 0.205 | 0.215 | 0.225 |
| D | 0.575 | 0.600 | 0.625 |
| E | 0.275 | 0.300 | 0.325 |
| e | 0.36 BSC |  |  |
| L | 0.145 | 0.155 | 0.165 |

GENERIC MARKING DIAGRAM*


X = Specific Device Code
*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present. Some products may not follow the Generic Marking.

## RECOMMENDED

 SOLDER FOOTPRINT*

DIMENSIONS: MILLIMETERS
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| ---: | :--- | :--- | :--- |
| DESCRIPTION: | X4DFN2, 0.60x0.30,0.36P | PAGE 1 OF 1 |

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NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.

|  | MILLIMETERS |  |  |
| :---: | :---: | :---: | :---: |
| DIM | MIN | NOM | MAX |
| A | 0.250 | 0.275 | 0.300 |
| A1 | 0.000 | 0.025 | 0.050 |
| b | 0.140 | 0.155 | 0.170 |
| D | 0.570 | 0.600 | 0.630 |
| E | 0.270 | 0.300 | 0.330 |
| E | 0.36 BSC |  |  |
| L | 0.190 | 0.215 | 0.240 |

GENERIC
MARKING DIAGRAM*

X

X = Specific Device Code
*This information is generic. Please refer to device data sheet for actual part marking. $\mathrm{Pb}-$ Free indicator, " G " or microdot " $\bullet$ ", may or may not be present. Some products may not follow the Generic Marking.


DIMENSIONS: MILLIMETERS
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| DESCRIPTION: | WLCSP2, 0.6X0.3 | PAGE 1 OF 1 |

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